

DESCRIPTION

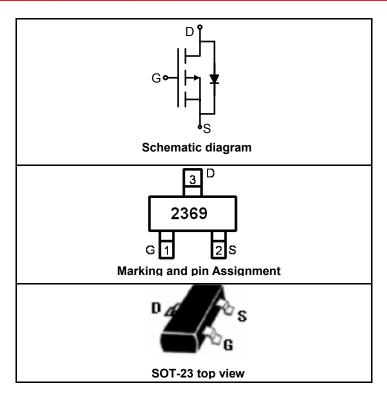
The SSF2369 uses advanced trench technology to provide excellent $R_{DS(ON)}$, low gate charge and operation with gate voltages as low as 2.5V. This device is suitable for use as a load switch or in PWM applications.

GENERAL FEATURES

- V_{DS} = -20V, I_{D} = -3A $R_{DS(ON)}$ < 100mΩ @ V_{GS} =-2.5V $R_{DS(ON)}$ < 80mΩ @ V_{GS} =-4.5V
- High Power and current handing capability
- Lead free product is acquired
- Surface Mount Package

Application

- ●PWM applications
- Load switch
- Power management



PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Device Package	Reel Size	Tape width	Quantity
2369	SSF2369	SOT-23	Ø180mm	8 mm	3000 units

ABSOLUTE MAXIMUM RATINGS(TA=25℃ unless otherwise noted)

Parameter	Symbol	Limit	Unit
Drain-Source Voltage	VDS	-20	V
Gate-Source Voltage	V _G s	±10	V
Drain Current Continuous@ Current Bulead (Note 1)	I _D	-3	Α
Drain Current-Continuous@ Current-Pulsed (Note 1)	I _{DM}	-10	А
Maximum Power Dissipation	P _D	1.25	W
Operating Junction and Storage Temperature Range	T_{J}, T_{STG}	-55 To 150	$^{\circ}$ C

THERMAL CHARACTERISTICS

Thermal Resistance, Junction-to-Ambient (Note 2)	$R_{\theta JA}$	100	°C/W
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ELECTRICAL CHARACTERISTICS (TA=25°C unless otherwise noted)

Parameter	Symbol	Condition	Min	Тур	Max	Unit
OFF CHARACTERISTICS						
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V I _D =-250μA	-20			V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =-20V,V _{GS} =0V			-1	μA
Gate-Body Leakage Current	I _{GSS}	V _{GS} =±10V,V _{DS} =0V			±100	nA



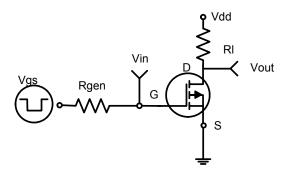
$V_{GS(th)}$	V _{DS} =V _{GS} ,I _D =-250μA	-0.5	-0.8	-1	V
$R_{DS(ON)} = \frac{V_{GS}=-4.5V, I_{D}=-4A}{V_{GS}=-2.5V, I_{D}=-2A}$	V _{GS} =-4.5V, I _D =-4A		69	80	mΩ
		85	100	11177	
G FS	V _{DS} =-5V,I _D =-5A		9		S
C _{lss}	V _{DS} =-10V,V _{GS} =0V, F=1.0MHz		1160		PF
C _{oss}			210		PF
C _{rss}			125		PF
t _{d(on)}	V _{DD} =-10V,I _D =-3A V _{GS} =-4.5V,R _{GEN} =3Ω		13.6	27.2	nS
t _r			8.6	17.2	nS
t _{d(off)}			73.6	147.2	nS
t _f			34.6	69.2	nS
Qg			9.6	12.7	nC
Q_{gs}	V _{DS} =-10V,I _D =-3A,V _{GS} =-4.5V		1.1		nC
Q_{gd}			2.6		nC
•	•	•	•		
V_{SD}	V _{GS} =0V,I _S =-1.25A			-1.2	V
Is				-2.8	Α
	$R_{DS(ON)}$ g_{FS} C_{Iss} C_{oss} C_{rss} $t_{d(on)}$ t_r $t_{d(off)}$ t_f Q_g Q_{gs} Q_{gd} V_{SD}	$R_{DS(ON)} = \begin{array}{c} V_{GS} = -4.5 \text{V}, \ I_D = -4 \text{A} \\ V_{GS} = -2.5 \text{V}, \ I_D = -2 \text{A} \\ \end{array}$	V _{GS} =-4.5V, I _D =-4A V _{GS} =-2.5V, I _D =-2A V _{DS} =-5V, I _D =-5A C _{ISS} C _{OSS} C _{TSS} V _{DS} =-10V, V _{GS} =0V, F=1.0MHz C _{TSS} V _{DD} =-10V, I _D =-3A V _{GS} =-4.5V, R _{GEN} =3Ω V _{DS} =-10V, I _D =-3A, V _{GS} =-4.5V Q _g Q _g Q _g V _{DS} =-10V, I _D =-3A, V _{GS} =-4.5V Q _g V _{DS} =-10V, I _D =-3A, V _{GS} =-4.5V Q _g V _{DS} =-10V, I _D =-3A, V _{GS} =-4.5V Q _g V _{DS} =-10V, I _D =-3A, V _{GS} =-4.5V Q _g V _{DS} =-10V, I _D =-3A, V _{DS} =-4.5V V _{DS} =-10V, I _D	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$	$\begin{array}{c ccccccccccccccccccccccccccccccccccc$

NOTES:

- Repetitive Rating: Pulse width limited by maximum junction temperature.
 Surface Mounted on FR4 Board, t ≤ 10 sec.
 Pulse Test: Pulse Width ≤ 300µs, Duty Cycle ≤ 2%.
 Guaranteed by design, not subject to production testing.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



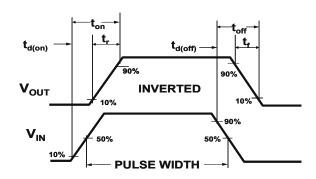


Figure1:Switching Test Circuit

Figure 2:Switching Waveforms

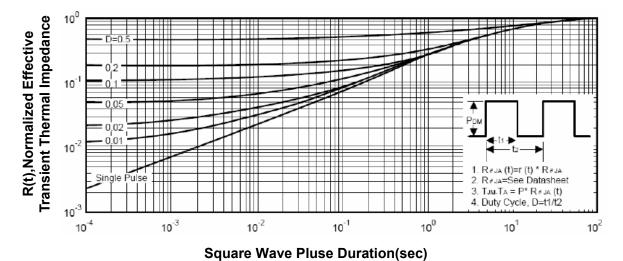
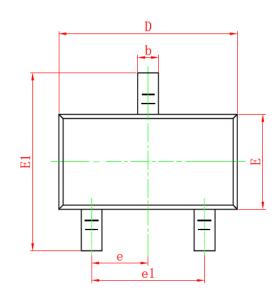


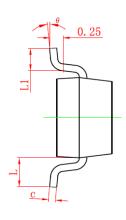
Figure 3: Normalized Maximum Transient Thermal Impedance



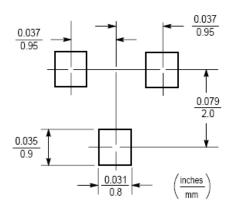
SOT-23 PACKAGE INFORMATION

Dimensions in Millimeters (UNIT:mm)









Cumbal	Dimensions in Millimeters				
Symbol	MIN.	MAX.			
Α	0.900	1.150			
A1	0.000	0.100			
A2	0.900	1.050			
b	0.300	0.500			
С	0.080	0.150			
D	2.800	3.000			
E	1.200	1.400			
E1	2.250	2.550			
е	0.950TYP				
e1	1.800	2.000			
L	0.550REF				
L1	0.300	0.500			
θ	0°	8°			

NOTES

- 1. All dimensions are in millimeters.
- 2. Tolerance ±0.10mm (4 mil) unless otherwise specified
- 3. Package body sizes exclude mold flash and gate burrs. Mold flash at the non-lead sides should be less than 5 mils.
- 4. Dimension L is measured in gauge plane.
- 5. Controlling dimension is millimeter, converted inch dimensions are not necessarily exact.



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